# **<u>MOSFET</u> - Power, Single** N-Channel, μ8FL 30 V, 17 mΩ, 22 A

# NVTFS4C25N

#### Features

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- NVTFS4C25NWF Wettable Flanks Product
- NVT Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Param	Parameter						
Drain-to-Source Voltage	Drain-to-Source Voltage						
Gate-to-Source Voltage	V <sub>GS</sub>	±20	V				
Continuous Drain		$T_A = 25^{\circ}C$	۱ <sub>D</sub>	10.1	А		
Current R <sub>θJA</sub> (Notes 1, 3, 5)	Steady State	T <sub>A</sub> = 85°C		7.8			
Power Dissipation $R_{\theta JA}$	T <sub>A</sub> = 25°C		PD	3.0	W		
(Notes 1, 3, 5)		T <sub>A</sub> = 85°C		1.8			
Continuous Drain		$T_C = 25^{\circ}C$	۱ <sub>D</sub>	22.1	А		
Current $R_{\psi JC}$ (Notes 1, 2, 4, 5)	Steady State	$T_{C} = 85^{\circ}C$		17.1			
Power Dissipation		$T_{C} = 25^{\circ}C$	PD	14.3	W		
$R_{\psi JC}$ (Notes 1, 2, 4, 5)		T <sub>C</sub> = 85°C		8.6			
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \ \mu s$		I <sub>DM</sub>	90	А		
Operating Junction and S	Т <sub>Ј</sub> , T <sub>stg</sub>	–55 to +175	°C				
Source Current (Body Die	۱ <sub>S</sub>	14	А				
Single Pulse Drain-to-So $(T_J = 25^{\circ}C, I_L = 6.7 A_{pk}, L$			E <sub>AS</sub>	11.2	mJ		
Lead Temperature for So (1/8" from case for 10 s)	Idering Pur	poses	ΤL	260	°C		

**MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise stated)

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- The entire application environment impacts the thermal resistance values shown; they are not constants and are valid for the specific conditions noted.
- 2. Psi  $(\psi)$  is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to a single case surface.
- 3. Surface-mounted on FR4 board using 650 mm<sup>2</sup>, 2 oz. Cu Pad.
- 4. Assumes heat-sink sufficiently large to maintain constant case temperature independent of device power.
- 5. Continuous DC current rating. Maximum current for pulses as long as one second is higher but dependent on pulse duration and duty cycle.

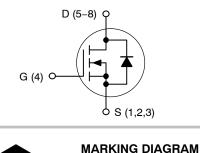


# **ON Semiconductor®**

#### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
30.1/	17 m $\Omega$ @ 10 V	22 A
30 V	26.5 mΩ @ 4.5 V	22 7

**N-Channel MOSFET** 



1 WDFN8 (μ8FL) CASE 511AB

4005

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ecific Dev	ice Code fo	r

4C25	= Specific Device Code for
	NVMTS4C25N
25WF	= Specific Device Code of
	NVTFS4C25NWF
А	= Assembly Location
Y	= Year
WW	= Work Week
•	= Pb-Free Package

(Note: Microdot may be in either location)

### ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit	
Junction-to-Case (Drain) (Notes 6, 7 and 9)	$\Psi_{\theta JC}$	10.5	°C 44/	
Junction-to-Ambient - Steady State (Notes 6 and 8)	$R_{\theta JA}$	50	°C/W	

6. The entire application environment impacts the thermal resistance values shown; they are not constants and are valid for the specific conditions noted.

7. Psi ( $\psi$ ) is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to a single case surface. 8. Surface–mounted on FR4 board using 650 mm<sup>2</sup>, 2 oz. Cu Pad.

9. Assumes heat-sink sufficiently large to maintain constant case temperature independent of device power.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

Parameter	Symbol	Test Cond	lition	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, I <sub>D</sub>	= 250 μA	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				15.3		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$			1.0	
		$V_{DS} = 24 V$	T <sub>J</sub> = 125°C			10	μA
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{G}$	<sub>S</sub> = ±20 V			±100	nA
ON CHARACTERISTICS (Note 10)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= 250 μA	1.3		2.2	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-4.5		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 10 A		13	17	
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 9 A		21	26.5	mΩ
Forward Transconductance	<b>9</b> FS	V <sub>DS</sub> = 1.5 V,	I <sub>D</sub> = 15 A		23		S
Gate Resistance	R <sub>G</sub>	T <sub>A</sub> = 25	°C		1.0		Ω
CHARGES AND CAPACITANCES					•		
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 15 V			500		1
Output Capacitance	C <sub>OSS</sub>				295		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				85		
Capacitance Ratio	C <sub>RSS</sub> /C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 1	5 V, f = 1 MHz		0.170		
Total Gate Charge	Q <sub>G(TOT)</sub>				5.1		
Threshold Gate Charge	Q <sub>G(TH)</sub>				0.9		
Gate-to-Source Charge	Q <sub>GS</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 20 A			1.7		nC
Gate-to-Drain Charge	Q <sub>GD</sub>				2.7		1
Gate Plateau Voltage	V <sub>GP</sub>				3.3		V
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ =	15 V; I <sub>D</sub> = 20 A		10.3		nC
SWITCHING CHARACTERISTICS (Note	11)				•		•
Turn–On Delay Time	t <sub>d(ON)</sub>				8.0		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>I</sub>	ns = 15 V.		32		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = 10 \text{ A}, \text{ R}_G$			10		ns
Fall Time	t <sub>f</sub>				3.0		1
Turn-On Delay Time	t <sub>d(ON)</sub>				4.0		İ
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>I</sub>	<sub>DS</sub> = 15 V,		25		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	V <sub>GS</sub> = 10 V, V <sub>I</sub> I <sub>D</sub> = 15 A, R <sub>G</sub>	= 3.0 Ω		13		ns
					i	i	1

10. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.

11. Switching characteristics are independent of operating junction temperatures.

tf

2.0

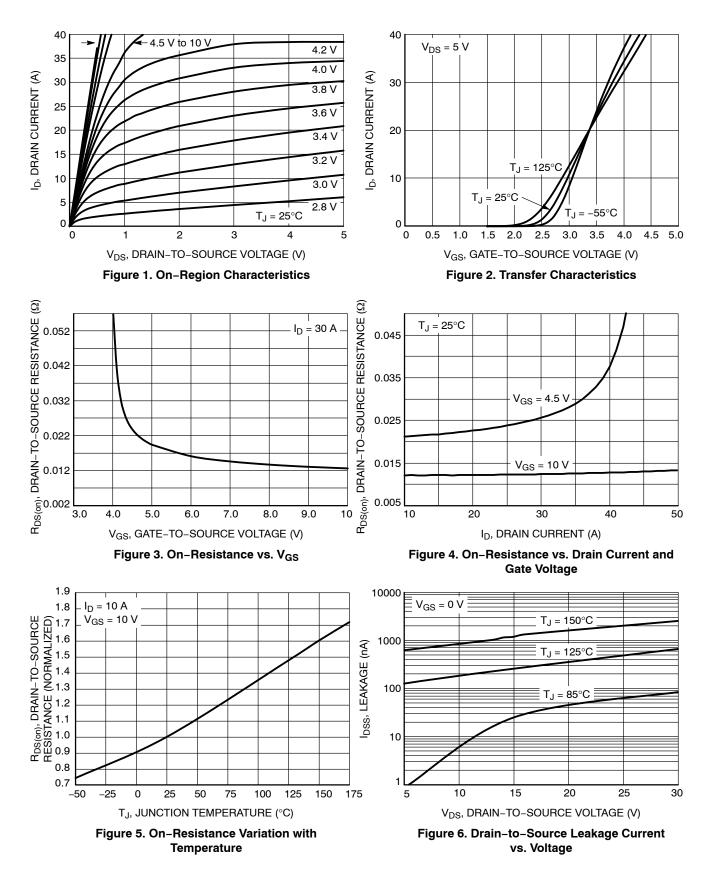
Fall Time

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

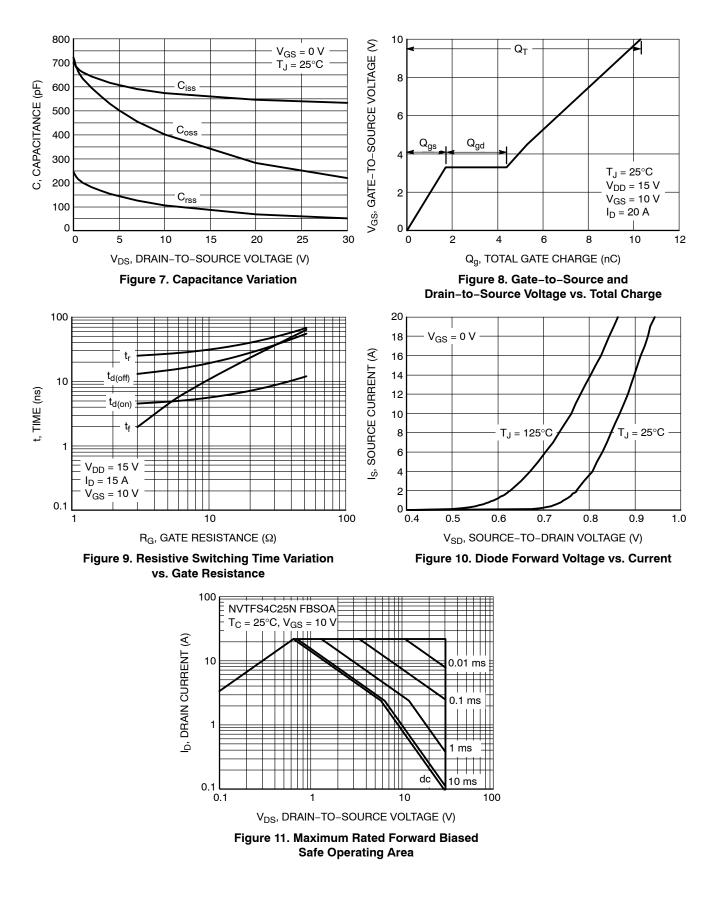
Parameter	Symbol	Test Condi	tion	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTIC	S						
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 10 A	$T_J = 25^{\circ}C$		0.87	1.2	V
		l <sub>S</sub> = 10 A	$T_J = 125^{\circ}C$		0.75		v
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dIS/dt = 100 A/µs, I <sub>S</sub> = 30 A			18.2		
Charge Time	ta				9.8		ns
Discharge Time	t <sub>b</sub>				8.4		
Reverse Recovery Charge	Q <sub>RR</sub>				5.7		nC

10. Pulse Test: pulse width  $\leq$  300 µs, duty cycle  $\leq$  2%. 11. Switching characteristics are independent of operating junction temperatures.

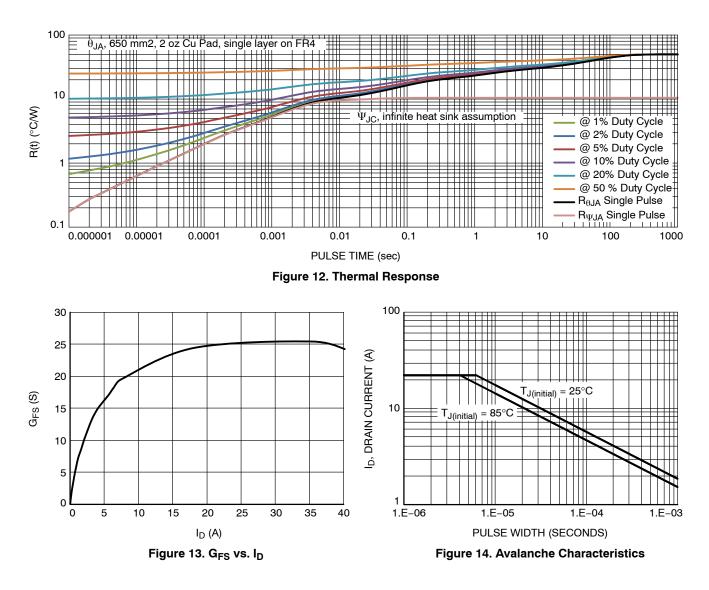
#### **TYPICAL CHARACTERISTICS**



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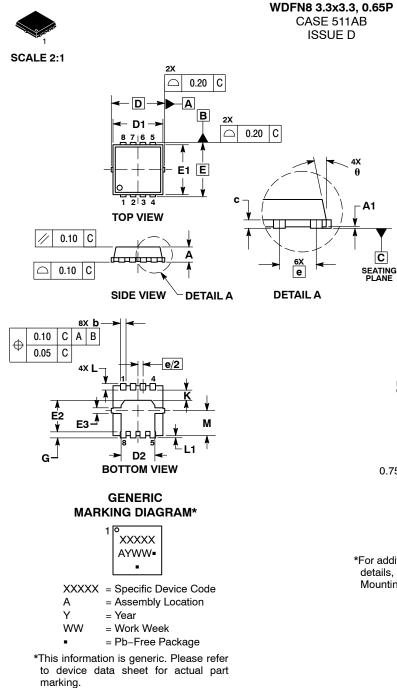


#### **ORDERING INFORMATION**

Device	Marking	Package	<b>Shipping</b> <sup>†</sup>
NVTFS4C25NTAG	4C25	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFS4C25NWFTAG	25WF	WDFN8 (Pb–Free)	1500 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





Pb-Free indicator, "G" or microdot " .", may or may not be present.

DATE 23 APR 2012

NOTES:

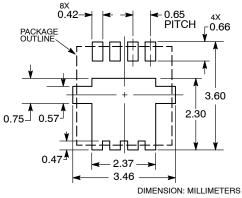
DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. DIMENSION D1 AND E1 D0 NOT INCLUDE MOLD FLASH 1. 2.

З. RS.

PROTRUSIONS OR GATE BUR

	МІ	LLIMETE	RS		INCHES	
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
с	0.15	0.20	0.25	0.006	0.008	0.010
D		3.30 BSC		0.130 BSC		
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E	3.30 BSC			0	.130 BSC	)
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е	0.65 BSC			0.026 BSC		
G	0.30	0.41	0.51	0.012	0.016	0.020
к	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
м	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °

**SOLDERING FOOTPRINT\*** 



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	WDFN8 3.3X3.3, 0.65P		PAGE 1 OF 1				
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